

Search Notes

Application/Control No.

10/817,195

Examiner

Patrick J. Lee

Applicant(s)/Patent under
Reexamination

QUINONES ET AL.

Art Unit

2878

SEARCHED

Class	Subclass	Date	Examiner
250	214.1, 239, 551	2/21/06 2/23/06	PL
257	80-82	↓	PL
257	723, 738		PL
257	783, 790		PL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted w/ S. Allen AU 2878 CI 250	10/18/2005	PL
250/214.1, 239, 551; 257/80-82, 723, 738, 783, 790 (see East printout attached)	10/18/2005	PL
East (see attached) - USPAT, US-PGPUB, EPO, JPO, DERWENT	2/21/2006	PL
East (see attached) - USPAT, US-PGPUB, EPO, JPO, DERWENT	2/23/2006	PL